

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/626,742	HISANO, ATSUSHI		
Examiner	Art Unit		
Tai T Mauven	2632		

	SEARCHED				
Class	Subclass	Date	Examiner		
340	568	1/20/2006	TN		
340	686.4	1/20/2006	TN		
340	686.6	1/20/2006	TN		
340	573.1	1/20/2006	TN		
340	687	1/20/2006	TN		
119	858	1/20/2006	TN		
119	859	1/20/2006	TN		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEAR (INCLUDING SI	CH NOTE EARCH S	:5 TRATEGY	)
		DATE	EXMR
EAST SEARCH		1/20/2006	TN
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